

U.S. UTILITY Patent Application

PATENT NUMBER and ISSUE DATE

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APPL NUM	FILING DATE	CLASS	SUBCLASS	GAU		EXAMINER Susanche	
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oreign priority claimed ☐ yes ☐ no					ATTORNEY DOCKET NO		
35 USC 119 conditions met ☐ yes ☐ no Verified and Acknov/ledged Examiners's initials 67,2						00-635	
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OWANCE MAILED		CLAIMS ALLOWED					
	Assistant Examiner	Total Claims		Print Claim for O.G			
UE FEE		DRAWING					
Date Paid		Sheets Drwg.	Figs.Drwg.	Print Fig.			
<u> </u>	Primary Examiner		<u> </u>				
RMINAL	PREPARED FOR ISSUE	Application Examiner					
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	UE FEE Date Paid	Assistant Examiner UE FEE Date Paid Primary Examiner RMINAL PREPARED FOR ISSUE WARNING: The information disclose Unauthorized disclosure may be prohibined by the prohibine sections 122, 181 and 368, Possession of the prohibine s	Assistant Examiner Total Claims Date Paid Primary Examiner PREPARED FOR ISSUE Application WARNING: The information disclosed herein may be Unauthorized disclosure may be prohibited by the Units Sections 122, 181 and 368, Possession outside the U.S.	Assistant Examiner Total Claims Pr O. Date Paid Primary Examiner PREPARED FOR ISSUE DISCLAMER WARNING: The information disclosed herein may be restricted. Unauthorized disclosure may be prohibited by the United States Cod Sections 122, 181 and 368, Possession outside the U.S. Patent & Tra			